Notice of References Cited Application/Control No. 10/799,671 Examiner BEN H. LIU Applicant(s)/Patent Under Reexamination MUTIKAINEN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,480,474 B2	11-2002	Johnson et al.	370/260
*	В	US-2003/0108000 A1	06-2003	Chaney et al.	370/260
*	C	US-6,731,609 B1	05-2004	Hirni et al.	370/260
*	D	US-7,065,199 B1	06-2006	Hyllander et al.	379/211.02
*	Е	US-7,155,528 B2	12-2006	Tam, Terry	709/230
*	F	US-7,184,415 B2	02-2007	Chaney et al.	370/260
*	G	US-7,233,589 B2	06-2007	Tanigawa et al.	370/352
*	Ι	US-6,775,269	08-2004	Kaczmarczyk et al.	370/352
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.